

P-Channel 100-V (D-S) MOSFET

Description

The device is using trench DMOS technology. This advanced technology has been especially tailored to minimize $R_{\rm DS(ON)}$, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

The device meets the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- $R_{DS(ON)} = 50 \text{m}\Omega @ V_{GS} = -10V$
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

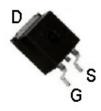
Typical Applications

- Networking
- Load Switch
- LED Applications
- Quick Charger

Package type: TO-263

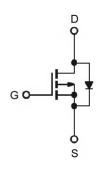
Packing & Order Information

800/Reel

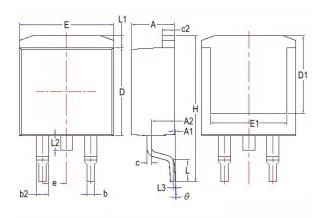


RoHS Compliant

Graphic Symbol

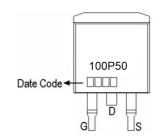


Package Dimension



REF.	Millimeter		REF.	Millimeter		
NEF.	Min.	Max.	NEF.	Min. 9.80 7.06 2.54 14.70 2.00 1.07 1.40 0.25	Max.	
Α	4.37	4.77	Е	9.80	10.36	
A1	0.00	0.25	E1	7.06	-	
A2	2.20	2.80	е	2.54	BSC	
b	0.70	0.96	Н	14.70	15.70	
b2	1.17	1.47	L	2.00	2.60	
С	0.30	0.60	L1	1.07	1.47	
c2	1.22	1.42	L2	1.40	1.75	
D	8.50	9.30	L3	0.25 BSC		
D1	6.60	-	θ	0°	9°	

Marking





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings				
Symbol	Parameter	Value	Units	
V_{DS}	Drain-Source Voltage	-100	V	
V_{GS}	Gate-Source Voltage	±20	V	
1	Continuous Drain Current ¹ (T _C =25°C)	-35	Α	
I _D	Continuous Drain Current ¹ (T _C =100°C)	-23	Α	
I _{DM}	Pulsed Drain Current ^{1,2}	-100	Α	
I _{AS}	Single Pulse Avalanche Current, L =0.1mH ³	-28	Α	
E _{AS}	Single Pulse Avalanche Energy, L =0.1mH ³	35.2	mJ	
Ъ	Power Dissipation ⁴ (T _C =25°C)	104	W	
P_D	Power Dissipation ⁴ (T _A =25°C)	2.5	W	
T _J /T _{STG}	Operating Junction and Storage Temperature	-55 to +150	°C	

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
$R_{\theta JA}$	Maximum Junction-to-Ambient ¹	62	°C/W		
R _{0JC}	Maximum Junction-to-Case ¹	1.2	°C/W		

Electrical Characteristics (T _J =25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$V_{GS\ (th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1.2	-1.8	-2.5	V
BV_{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-100	-	-	V
g _{fs}	Forward Transconductance	V _{DS} =-10V, I _D =-10A	-	32	-	S
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-100V, V _{GS} =0V, T _J =25°C		-	-1	μΑ
		V _{DS} =-80V, V _{GS} =0V, T _J =125°C	-		-10	
R _{DS (on)}	Static Drain-Source On-Resistance ²	V _{GS} =-10V, I _D =-20A	-	42	50	mΩ
		V_{GS} =-4.5V, I_{D} =-10A	-	46	55	
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =-50V, L =0.1mH, I _{AS} =-20A	20	-	-	mJ
V _{SD}	Diode Forward Voltage ²	I _S =-1A, V _{GS} =0V, T _J =25°C	-	-	-1.2	V
Is	Continuous Source Current ^{1,6}	V V OV Force Current	-	-	-35	
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V, Force Current	-	-	-70	Α

Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =-50V, V_{GS} =-10V, L=0.1mH, I_{AS} =-28A.
- 4. The power dissipation is limited by 150°C junction temperature.
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



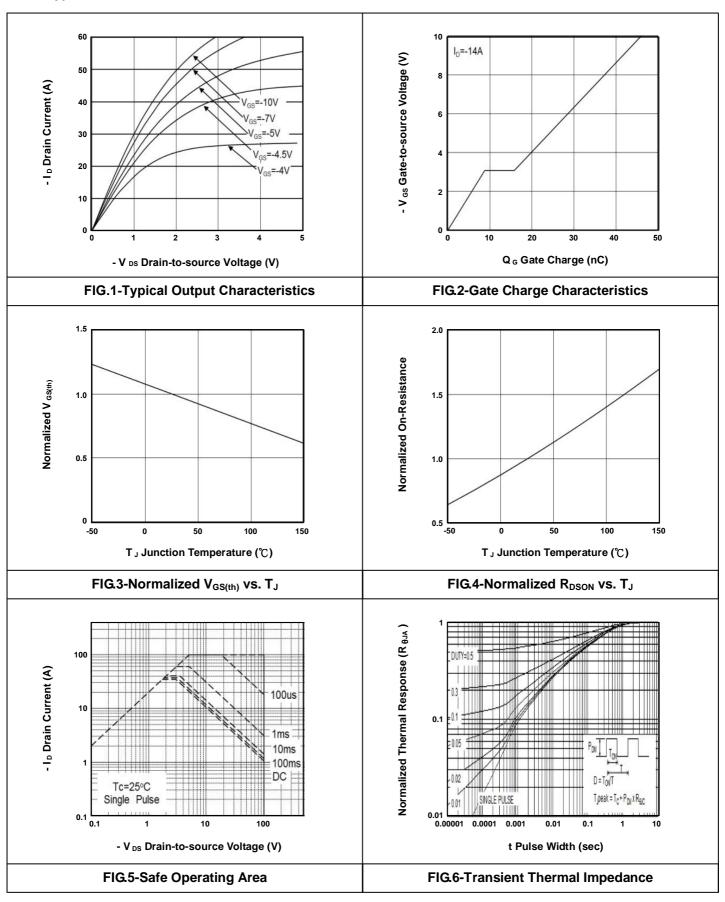
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Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =-80V		92		
Q_{gs}	Gate-Source Charge	I _D =-14A		18		nC
Q _{gd}	Gate-Drain Charge	V _{GS} =-10V		14		
t _{d(on)}	Turn-On Delay Time ²	V _{DS} =-50V		20		
t _r	Rise Time	I _D =-14A		32		
t _{d(off)}	Turn-Off Delay Time	V _{GS} =-10V		123		ns
t _f	Fall Time	$R_G = 3.3\Omega$		64		
C _{ISS}	Input Capacitance	V _{DS} =-25V		6500		
Coss	Output Capacitance	V _{GS} =0V		220		pF
C _{RSS}	Reverse Transfer Capacitance	f =1.0MHz		125		1



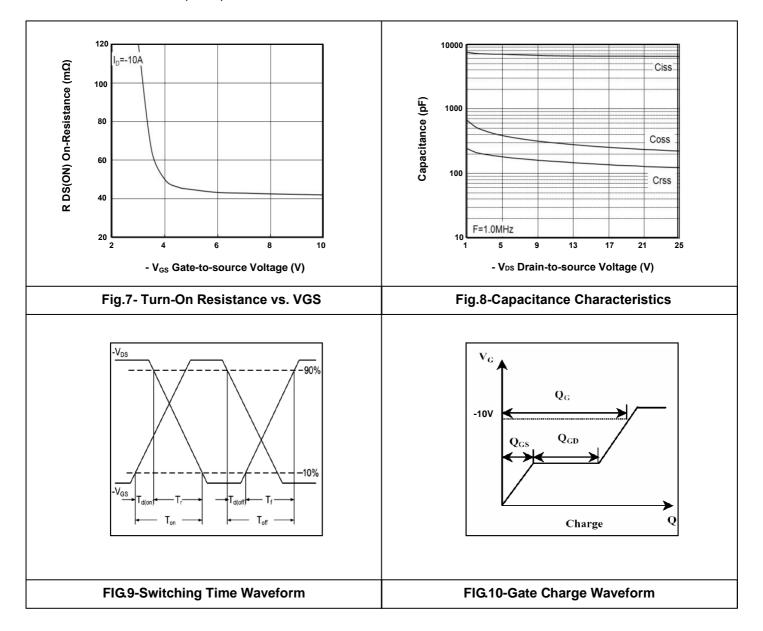
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Typical Electrical Characteristics





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